
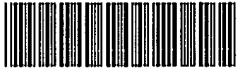


<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10602730</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>LEE, JOO-YUL</p>
	<p>Examiner</p> <p>Sherman, Stephen G</p>	<p>Art Unit</p> <p>2629</p>


Class	SubClass	Date	Examiner
345	168,60-63,66-69	07/20/2005	SS
345	204-205,208-210	07/21/2005	SS
315	169.4	07/21/2005	SS
345	55,58,60-72,204	9/13/2006	SS
315	169.1,169.3169.4,	9/13/2006	SS
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<b>Interference Searched</b>  	Application/Control No.  10602730	Applicant(s)/Patent Under Reexamination  LEE, JOO-YUL
	Examiner Sherman, Stephen G	Art Unit 2629

Class	SubClass	Date	Examiner
345	55,58,60-72,204	9/13/2006	SS
315	169.1,169.3,169.4	9/13/2006	SS

See attached search history

U.S. Patent and Trademark Office	Part of Paper No.: S
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<b>Search Notes</b>  	Application/Control No.  10602730	Applicant(s)/Patent Under Reexamination  LEE, JOO-YUL
	Examiner Sherman, Stephen G	Art Unit 2629

Notes	Date	Examiner
See attached search history		
Search Updated	12/07/2005	SS
Search Updated	05/18/2006	SS
Search Updated	9/13/2006	SS
NPL Documents Searched (ACM, INSPEC, IEEE)		
U.S. Patent and Trademark Office		Part of Paper No.: S